

RESPONSE UNDER 37 C.F.R. §1.116
EXPEDITED PROCEDURE - EXAMINING GROUP 2800

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

OK 8/25/07

In re Application)	<u>PATENT APPLICATION</u>
Inventors:)	
Frederick Ware, et al.)	
Application No.:)	
10/768,443)	Art Unit: 2829
Filed Date:)	
Jan. 30, 2004)	Examiner: Nguyen, T.
Title: METHOD AND APPARATUS FOR TEST)	
CHARACTERIZATION OF SEMICONDUCTOR)	Customer No.: 38456
COMPONENTS)	

RESPONSE TO OFFICE ACTION UNDER 37 C.F.R. §1.116

Mail Stop AF
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

This RESPONSE is in reply to the outstanding Office action.

AMENDMENTS to the CLAIMS begin on Page 2 of this RESPONSE.

REMARKS begin on Page 28 of this RESPONSE.